UMW IRFB4110

100V N-Channel MOSFET

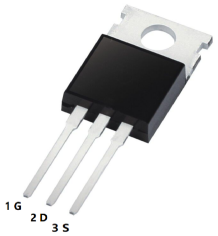
1.Features

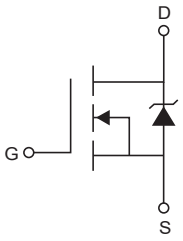
- $V_{DS(V)}$=100V
- I_D=120A
- $R_{DS(ON)}$<3.7mΩ(V_{GS}=10V)
- Improved Gate, Avalanche and Dynamic dv/dt Ruggedness
- Fully Characterized Capacitance and Avalanche SOA
- Enhanced body diode dV/dt and dI/dt Capability Lead Free
- RoHS Compliant, Halogen-Free

2.Pinning information

Pin	Symbol	Description
1	G	GATE
2	D	DRAIN
3	S	SOURCE

TO-220





3.Absolute Maximum Ratings

Parameter		Symbol	Rating	Units
Continuous Drain Current, V_{GS}=10V(Silicon Limited)	T_C=25°C	I_D	180 ①	A
Continuous Drain Current, V_{GS}=10V (Silicon Limited)	T_C=100°C		130 ①	A
Continuous Drain Current, V_{GS}=10V (Wire Bond Limited)	T_C=25°C		120	A
Pulsed Drain Current ②		I_{DM}	670	A
Maximum Power Dissipation	T_C=25°C	P_D	370	W
Linear Derating Factor			2.5	W/°C
Gate-to-Source Voltage		V_{GS}	±20	V
Peak Diode Recovery ④		dv/dt	5.3	V/ns
Storage Temperature Range		T_J, T_{STG}	-55 to 175	°C
Soldering Temperature, for 10 seconds (1.6mm from case)			300	°C
Mounting torque, 6-32 or M3 screw			10lbin (1.1Nm)	

Single Pulse Avalanche Energy ③	$E_{AS(Thermally\ limited)}$	190	mJ
Avalanche Current ②	I_{AR}	See Fig. 18, 20 22a, 22b	A
Repetitive Avalanche Energy ⑤	E_{AR}		mJ

4.Thermal resistance rating

Parameter	Symbol	Typ	Max	Units
unction-to-Case ⑨	$R_{\theta JC}$		0.402	°C/W
Case-to-Sink, Flat Greased Surface	$R_{\theta CS}$	0.5		°C/W
Junction-to-Ambient ⑧	$R_{\theta JA}$		62	°C/W

5.Electrical Characteristics @ T_J= 25°C (unless otherwise specified)

Parameter	Symbol	Conditions	Min	Typ	Max	Units
Drain-to-Source Breakdown Voltage	$V_{(BR)DSS}$	I_D=250μA, V_{GS}=0V	100			V
Breakdown Voltage Temp. Coefficient	$\Delta V_{(BR)DSS}/\Delta T_J$	Reference to 25°C,I_D=5mA②		0.018		V/°C
Static Drain-to-Source On-Resistance	$R_{DS(ON)}$	V_{GS}=10V, I_D=75A ⑤		3.7	8.4	mΩ
Gate Threshold Voltage	$V_{GS(th)}$	V_{DS}=V_{GS}, I_D=250μA	2		4	V
Drain-to-Source Leakage Current	I_{DSS}	V_{DS}=100V, V_{GS}=0V			20	μA
		V_{DS}=100V, V_{GS}=0V, T_J=125°C			250	μA
Gate-to-Source Forward Leakage	I_{GSS}	V_{GS}=20V			100	nA
Gate-to-Source Reverse Leakage		V_{GS}=-20V			-100	nA
Forward Transconductance	g_{FS}	V_{DS}=50V, I_D=75A	160			S
Total Gate Charge	Q_g	I_D=75A, V_{DS}=50V, V_{GS}=10V⑤		150	210	nC
Gate-to-Source Charge	Q_{gs}			35		nC
Gate-to-Drain ("Miller") Charge	Q_{gd}			43		nC
Gate Resistance	R_G			1.3		Ω
Tum-On Delay Time	$t_{D(on)}$	V_{DD}=65V, I_D=75A R_G=2.6Ω, V_{GS}=10V ⑤		25		ns
Rise Time	t_r			67		ns
Turn-Off Delay Time	$t_{D(off)}$			78		ns
Fall Time	t_f			88		ns
Input Capacitance	C_{iss}	V_{GS}=0V, V_{DS}=50V f=1MHz		9620		pF
Output Capacitance	C_{oss}			670		pF
Reverse Transfer Capacitance	C_{rss}			250		pF
Effective Output Capacitance (Energy Related)	C_{oss}eff.(ER)	V_{GS}=0V, V_{DS}=0V to 80V ⑦		820		pF
Effective Output Capacitance (Time Related)	C_{oss}eff.(TR)	V_{GS}=0V, V_{DS}=0V to 80V ⑥		950		pF

Diode Characteristics						
Continuous Source Current (Body Diode)	I_S	MOSFET symbol showing the integral reverse p-n junction diode.			170①	A
Pulsed Source Current (Body Diode) ②⑦	I_{SM}				670	A
Diode Forward Voltage	V_{SD}	T_J=25°C,I_S=75A,V_{GS}=0V ⑤			1.3	V
Reverse Recovery Time	t_{rr}	T_J=25°C, V_R=85V		50	75	ns
		T_J=125°C, I_F=75A		60	90	ns
Reverse Recovery Charge	Q_{rr}	T_J=25°C, di/dt=100A/μs ⑤		94	140	nC
		T_J=125°C		140	210	nC
Reverse Recovery Current	I_{RRM}	T_J=25°C		3.5		A
Forward Turn-On Time	t_{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L_S+L_D)				

Notes:

① Calculated continuous current based on maximum allowable junction temperature. Bond wire current limit is 120A by source bonding technology. Note that current limitations arising from heating of the device leads may occur with some lead mounting arrangements.

② Repetitive rating; pulse width limited by max. junction temperature.

③ Limited by T_{Jmax}, starting T_J=25°C, L=0.033mH, R_G=25Ω, I_{AS}=108A, V_{GS}=10V. Part not recommended for use above this value.

④ I_{SD} ≤ 75A, di/dt ≤ 630A/μs, V_{DD} ≤ $V_{(BR)DSS}$, T_J ≤ 175°C.

⑤ Pulse width ≤ 400μs; duty cycle ≤ 2%.

⑥ C_{oss} eff. (TR) is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}.

⑦ C_{oss} eff. (ER) is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}.

⑧ R_θ is measured at T_J approximately 90°C.

6.1Typical Characterisitics

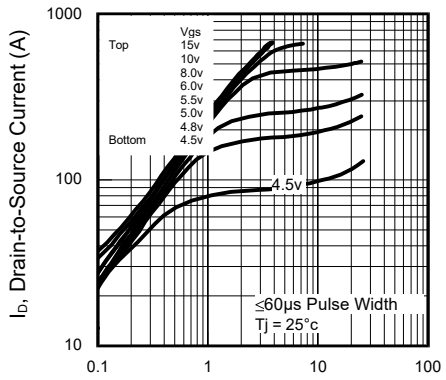


Figure 1: Typical On-Resistance vs. Gate Voltage

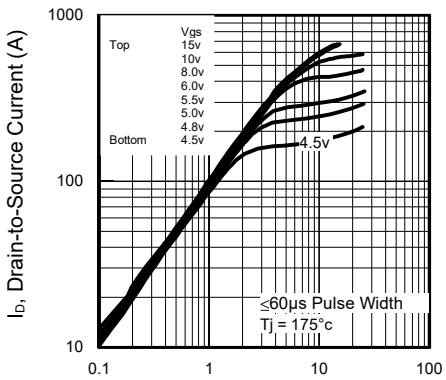


Figure 2: Typical Output Characteristics

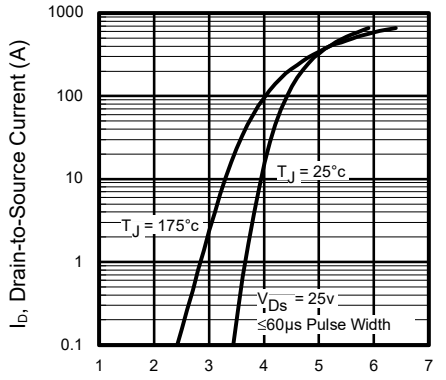


Figure 3: Typical Output Characteristics

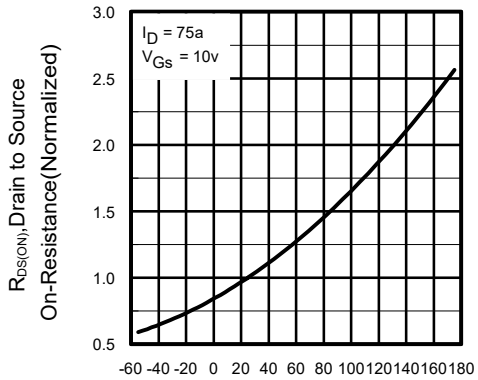


Figure 4: Normalized On-Resistance vs. Temperature

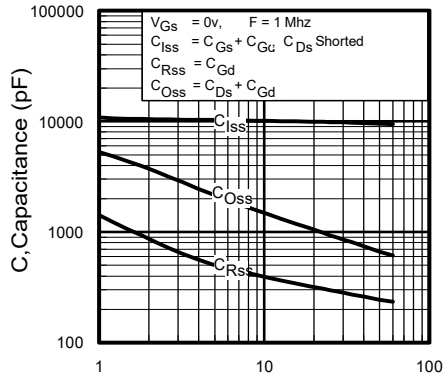


Figure 5: Typical Capacitance vs. Drain-to-Source Voltage

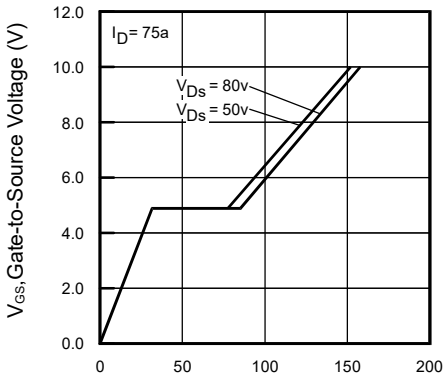


Figure 6: Typical Gate Charge vs.

6.2Typical Characterisitics

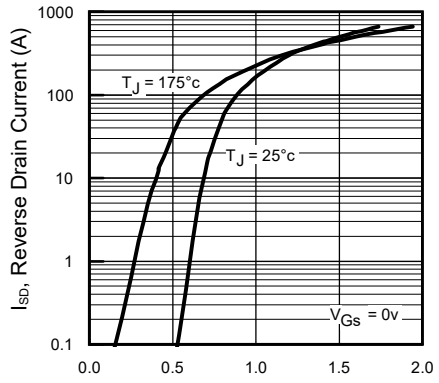


Figure 7: Typical Capacitance vs. Drain-to-Source Voltage

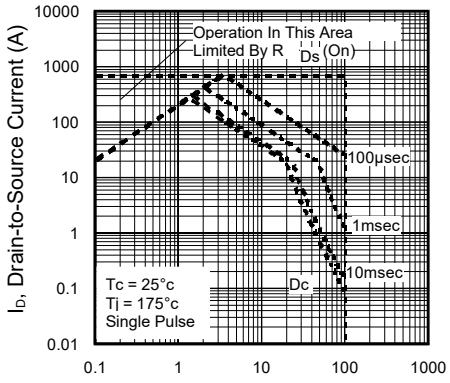


Figure 8: Maximum Safe Operating Area

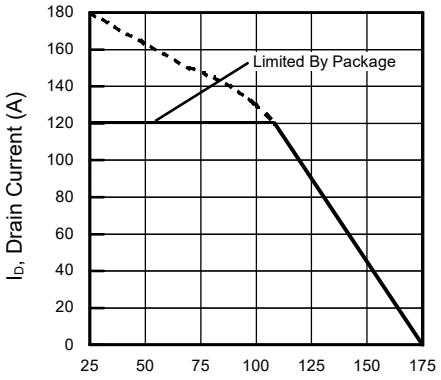


Figure 9: Maximum Drain Current vs. Case Temperature

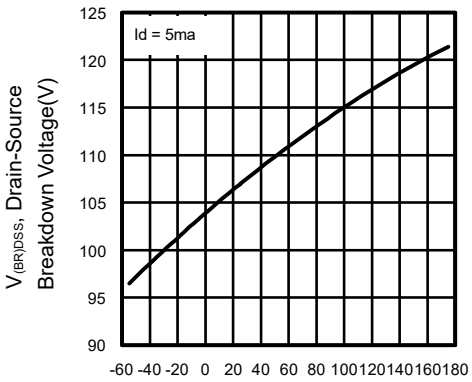


Figure 10: Drain-to-Source Breakdown Voltage

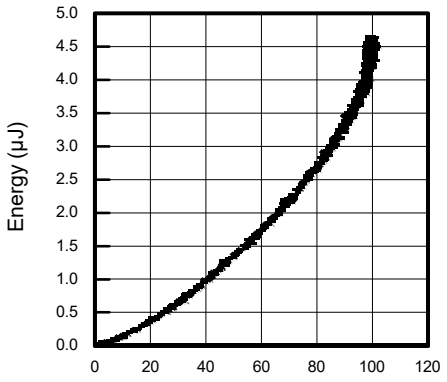


Figure 11: Typical C_{OSS} Stored Energy

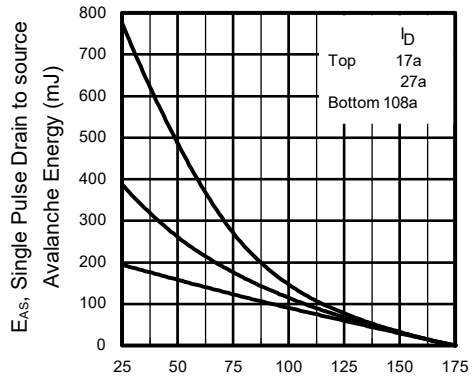


Figure 12: Maximum Avalanche Energy vs. DrainCurrent

6.3Typical Characterisitics

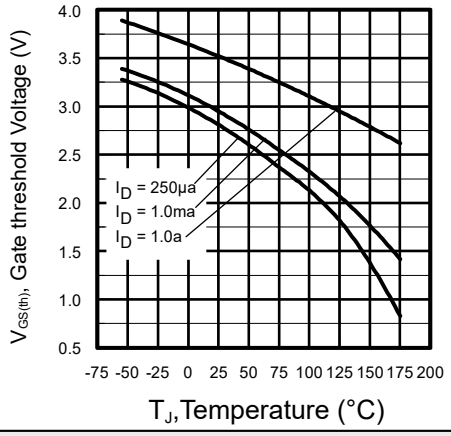


Figure 13: Threshold Voltage vs. Temperature

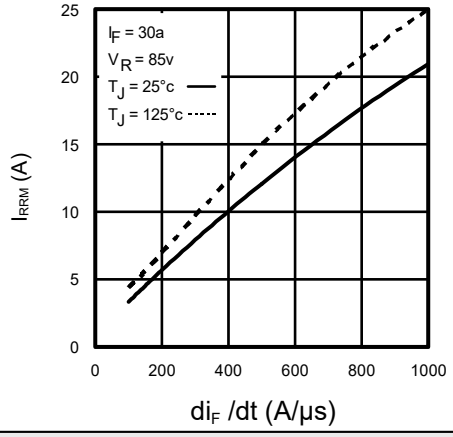


Figure 14: Typical Recovery Current vs. dif/dt

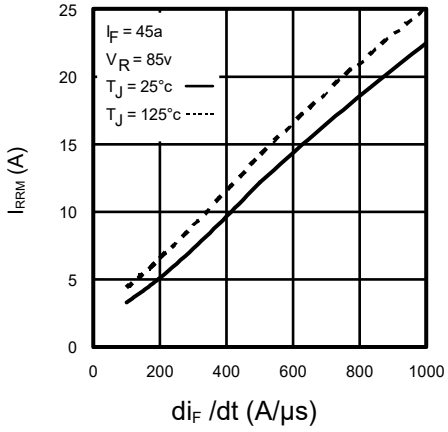


Figure 15: Typical Recovery Current vs. dif/dt

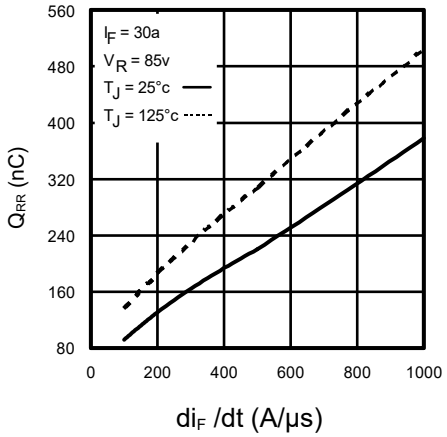


Figure 16: Typical Stored Charge vs. dif/dt

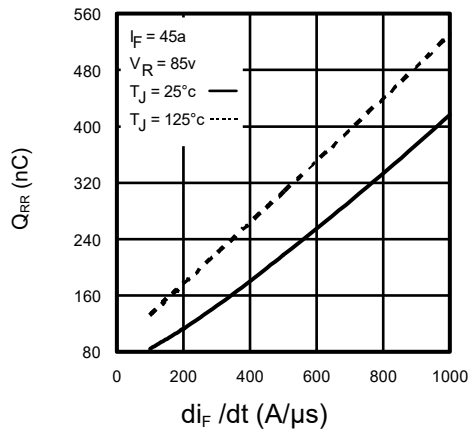


Figure 17: Typical Stored Charge vs. di_f/dt

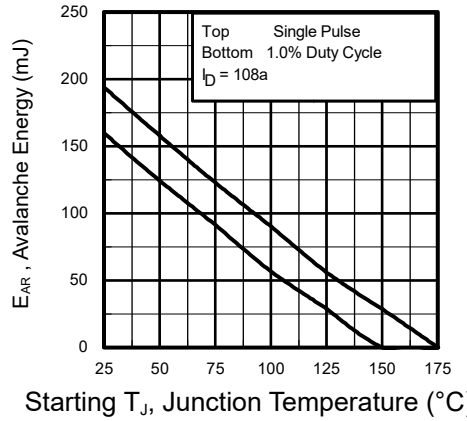


Figure 18: Maximum Avalanche Energy vs. Temperature

6.4Typical Characterisitics

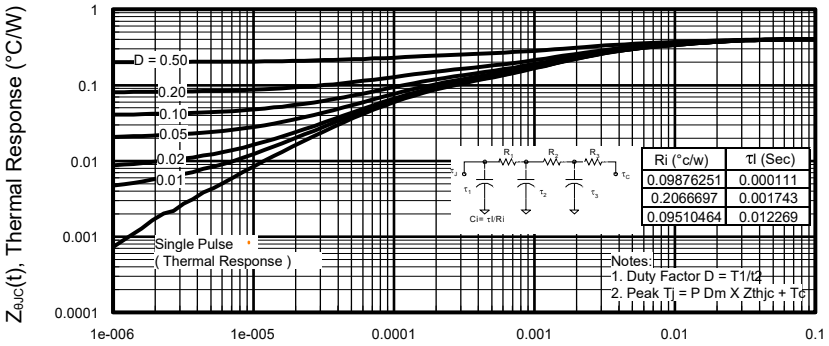


Figure 19: Maximum Effective Transient Thermal Impedance, Junction-to-Case

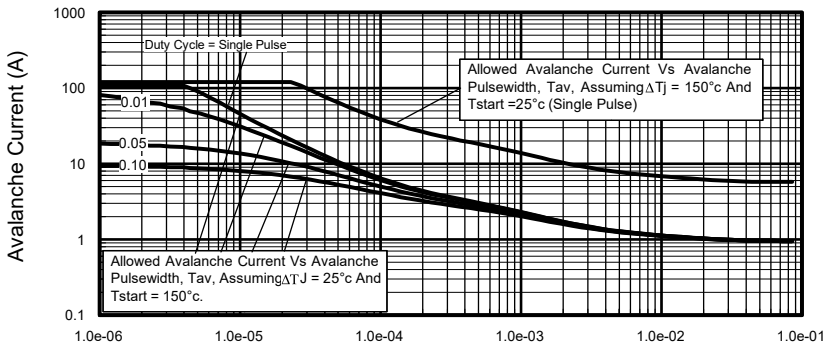


Figure 20: Typical Avalanche Current vs.Pulse width

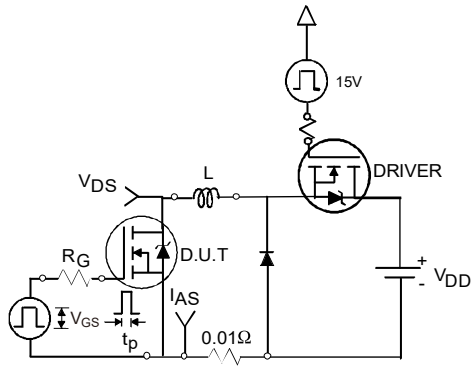


Figure 21a: Unclamped Inductive Test Circuit

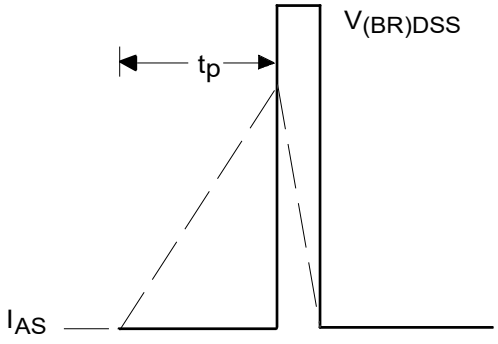


Figure 21b: Unclamped Inductive Waveforms

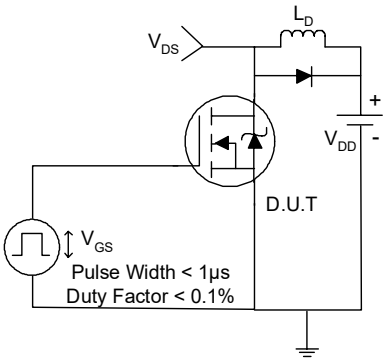


Figure 22a: Switching Time Test Circuit

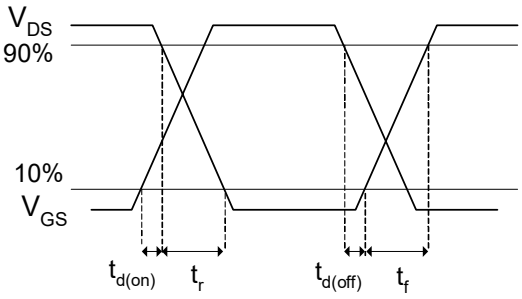


Figure 22b: Switching Time Waveforms

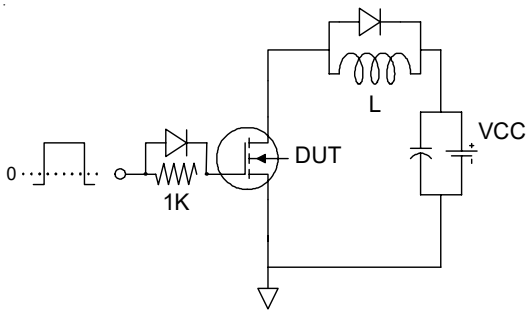


Figure 23a: Gate Charge Test Circuit

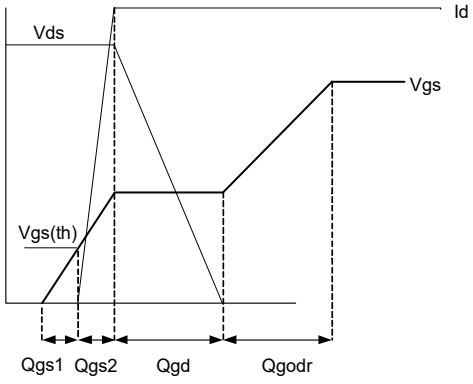


Figure 23b: Gate Charge Waveform

Notes on Repetitive Avalanche Curves , Figures 18, 20:

1.Avalanche failures assumption: Purely a thermal phenomenon and failure occurs at a temperature far in excess of T_{jmax}.

This is validated for every part type.

2. Safe operation in Avalanche is allowed as long asT_{jmax} is not exceeded.

3. Equation below based on circuit and waveforms shown in Figures 23a, 23b.

4. $P_{D\ (ave)}$ = Average power dissipation per single avalanche pulse.

5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).

6. I_{av} = Allowable avalanche current.

7. ΔT = Allowable rise in junction temperature, not to exceed T_{jmax} (assumed as 25°C in Figure 18, 20).

t_{av} = Average time in avalanche.

D = Duty cycle in avalanche = t_{av} ·f

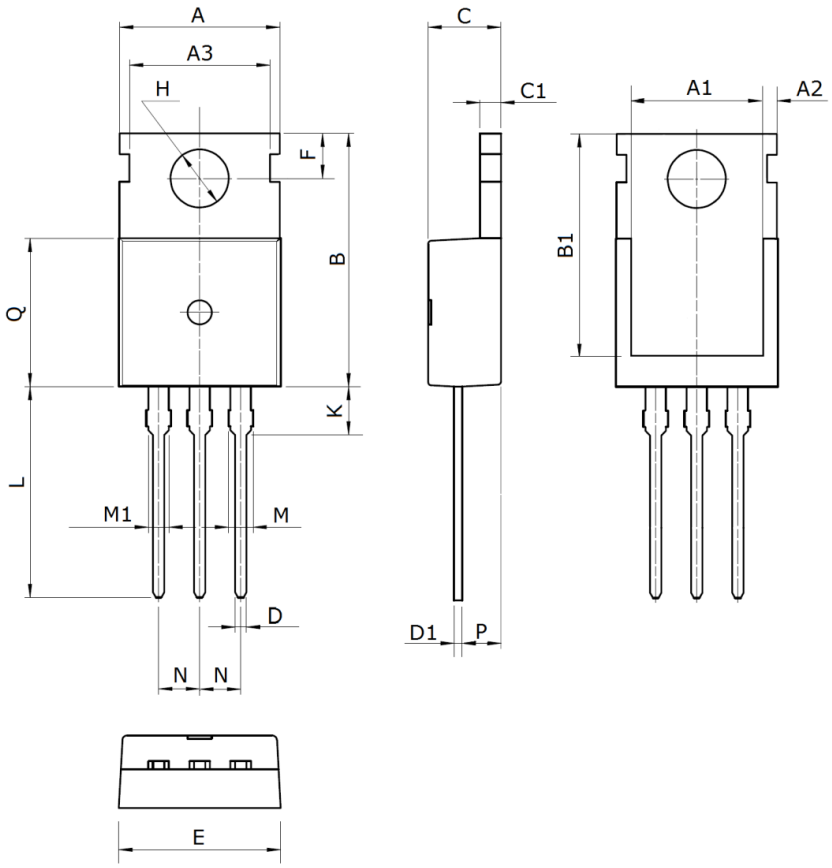
$Z_{thJC}(D, t_{av})$ = Transient thermal resistance, see Figure 19)

P_D (ave) = 1/2 (1.3·BV·I_{av}) = ΔT/ Z_{thJC}

I_{av} = 2ΔT/ [1.3·BV·Zth]

$E_{AS\ (AR)}$ = P_D (ave)·t_{av}

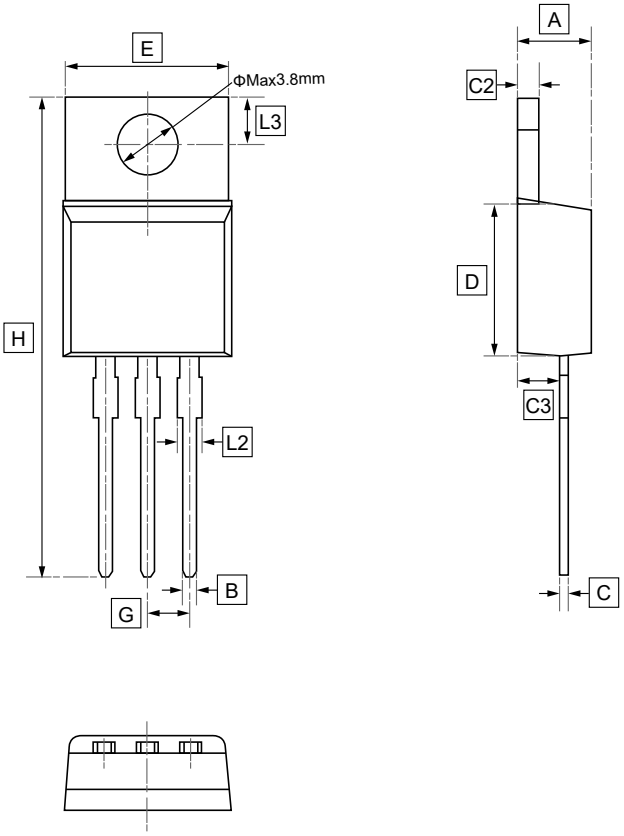
7.1 TO-220 Package Outline Dimensions



DIMENSIONS (mm are the original dimensions)

Symbol	Dimensions(mm)	Symbol	Dimensions(mm)	Symbol	Dimensions(mm)
A	10.0±0.3	C1	1.3±0.2	L	13.2±0.4
A1	8.0±0.2	D	0.8±0.2	M	1.38±0.1
A2	0.94±0.1	D1	0.5±0.1	M1	1.28±0.1
A3	8.7±0.1	E	10.0±0.3	N	2.54(typ)
B	15.6±0.4	F	2.8±0.1	P	2.4±0.3
B1	13.2±0.2	H	3.6±0.1	Q	9.15±0.25
C	4.5±0.2	K	3.1±0.2		

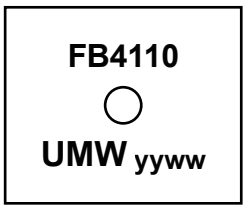
7.2 TO-220 Package Outline Dimensions



DIMENSIONS (mm are the original dimensions)

Symbol	A	B	C	C2	C3	D	E	G	H	L2	L3
Min	4.30	0.60	0.28	1.17	2.30	8.80	9.80	2.44	28.55	1.10	2.59
Max	4.70	1.00	0.48	1.37	2.70	9.20	10.20	2.64	29.15	1.50	2.89

8.Ordering information



yy: Year Code
ww: Week Code

Order Code	Package	Base QTY	Delivery Mode
UMW IRFB4110	TO-220	1000	Tube and box

9.Disclaimer

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